

P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON) max}	I _D T _A = +25°C
-20V	$65m\Omega @V_{GS} = -4.5V$	-4.2A
-20 V	100mΩ @ V_{GS} = -2.5 V	-3.4A

Description

This MOSFET has been designed to minimize the on-state resistance $(R_{\text{DS(ON)}})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Backlighting
- Power Management Functions
- DC-DC Converters
- Motor Control

Features

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

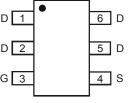
Mechanical Data

- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish MatteTin annealed over Copper leadframe.
 Solderable per MIL-STD-202, Method 208
- Weight: 0.0013 grams (approximate)

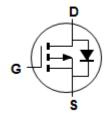




Top View



Top View Pin-Out



Internal Schematic

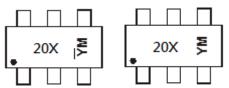
Ordering Information (Note 4)

Part Number	Case	Packaging		
DMP2033UVT-7	TSOT26	3000/Tape & Reel		
DMP2033UVT -13	TSOT26	10000/Tape & Reel		

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



Chengdu A/T Site Shanghai A/T Site

20X = Product Type Marking Code YM = Date Code Marking for SAT (Shanghai Assembly/ Test site) $\overline{\gamma}_M$ = Date Code Marking for CAT (Chengdu Assembly/ Test site) Y or $\overline{\gamma}$ = Year (ex: A = 2013) M = Month (ex: 9 = September)

Date Code Kev

Year	201	1	2012		2013	20	14	2015		2016	2	2017
Code	Υ		Z		Α	[3	С		D		Е
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D

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Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characte	eristic		Symbol	Value	Units
Drain-Source Voltage			V _{DSS}	-20	V
Gate-Source Voltage		V _{GSS}	±8	V	
Continuous Drain Current (Note 6) Steady $T_A = +25^{\circ}C$ State $T_A = +70^{\circ}C$			I _D	-4.2 -3.4	А
Pulsed Drain Current (Note 6)			I _{DM}	-10	А

Thermal Characteristics

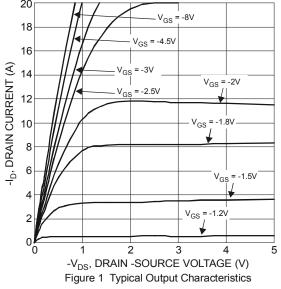
Characteristic	Symbol	Value	Units	
Total Power Dissipation (Note 5)		P _D	1.2	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ heta JA}$	100	°C/W	
Total Power Dissipation (Note 6)		P _D	1.7	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{ heta JA}$	74	°C/W
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C

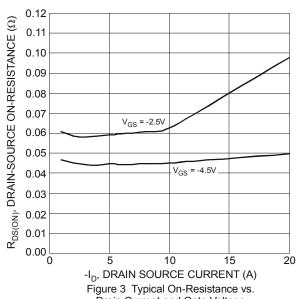
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

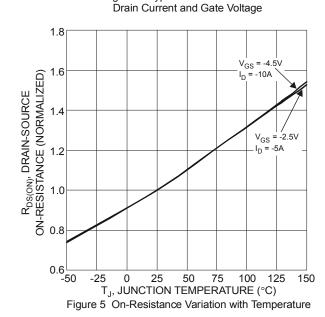
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)			•	•		
Drain-Source Breakdown Voltage		-20	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	_	_	-1.0	μΑ	V _{DS} = -20V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 8V$, $V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(th)}	-0.5	_	-0.9	٧	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
			45	65		V _{GS} = -4.5V, I _D = -4.2A
Static Drain-Source On-Resistance	R _{DS(ON)}	_	57	100	mΩ	V_{GS} = -2.5V, I_D = -3.4A
			80	200		$V_{GS} = -1.8V, I_D = -2A$
Forward Transfer Admittance	Y _{fs}	_	9	_	S	$V_{DS} = -5V, I_{D} = -4A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance		_	845	_	pF	
Output Capacitance		_	72	_	pF	$V_{DS} = -15V, V_{GS} = 0V$ - f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	63	_	pF	1 - 1.000112
SWITCHING CHARACTERISTICS (Note 8)						
Total Gate Charge	Q_g	_	10.4	_	nC	V 45V V 6V
Gate-Source Charge	Q_{gs}	_	1.5	_	nC	$V_{GS} = -4.5V$, $V_{DS} = -4V$, $I_{D} = -3.5A$
Gate-Drain Charge	Q_{gd}	_	1.9	_	nC	ID = -3.3A
Turn-On Delay Time	t _{D(on)}	_	6.5	_	ns	
Turn-On Rise Time	tr	_	13.4	_	ns	V _{DS} = -4V, V _{GS} = -4.5V,
Turn-Off Delay Time	t _{D(off)}	_	51.5	_	ns	$R_G = 6\Omega$, $I_D = -1A$
Turn-Off Fall Time	t _f	_	21.8	_	ns]

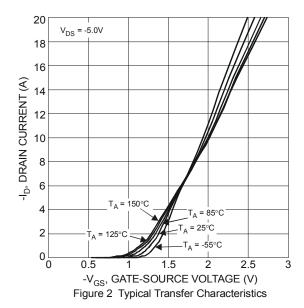
- Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.

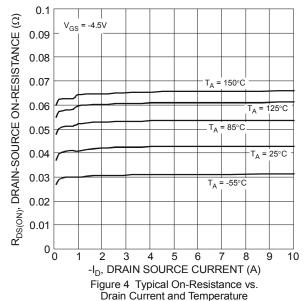


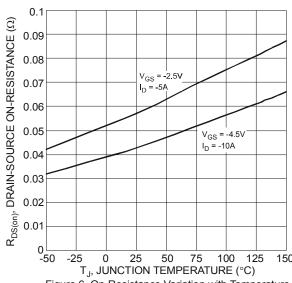














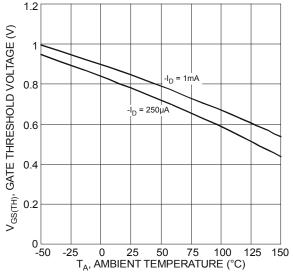
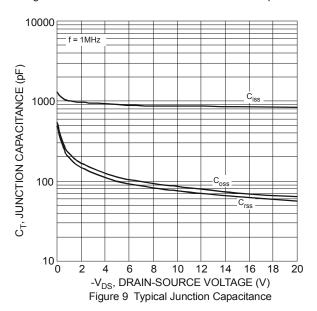
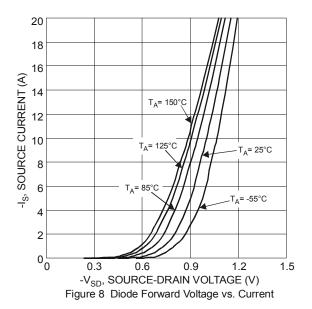
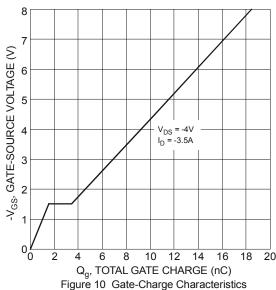


Figure 7 Gate Threshold Variation vs. Ambient Temperature

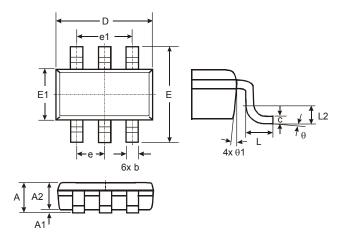






Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

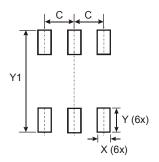


TSOT26							
Dim	Min	Max	Тур				
Α	I	1.00	-				
A 1	0.01	0.10	-				
A2	0.84	0.90	-				
D	-	_	2.90				
Е	Ī	_	2.80				
E1	_	_	1.60				
p	0.30	0.45	_				
С	0.12	0.20	_				
е	I	-	0.95				
e1	-	_	1.90				
L	0.30	0.50					
L2	ı	_	0.25				
θ	0°	8°	4°				
θ1	4°	12°	_				
All Dimensions in mm							
<u> </u>							



Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	0.950
Х	0.700
Υ	1.000
Y1	3.199

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